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TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCXH162827FT

Low-Voltage 20-Bit Bus Buffer with Bushold

The TC74VCXH162827FT is a high-performance CMOS 20-bit bus buffer. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The TC74VCXH162827FT is composed of two 10-bit sections with separate output-enable signals. For either 10-bit buffer section, the two output-enable ($1\overline{OE1}$ and $1\overline{OE2}$ or $2\overline{OE1}$ and $2\overline{OE2}$) inputs must both be low for the corresponding Y outputs to be active. When the \overline{OE} input is high, the outputs are in a high impedance state. This device is designed to be used with 3-state memory address drivers, etc.

The 26- Ω series resistor helps reducing output overshoot and undershoot without external resistor.

TSSOP56-P-0061-0.50A Weight: 0.25 g (typ.)

The A data inputs include active bushold circuitry, eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

All inputs are equipped with protection circuits against static discharge.

Features

- 26-Ω series resistors on outputs
- Low-voltage operation: $V_{CC} = 1.8$ to 3.6 V
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- High-speed operation: $t_{pd} = 3.4 \pmod{V_{CC}} = 3.0 \text{ to } 3.6 \text{ V}$

 $t_{pd} = 4.1 \text{ (max)} (V_{CC} = 2.3 \text{ to } 2.7 \text{ V})$

$$t_{pd} = 8.2 \text{ (max)} (V_{CC} = 1.8 \text{ V})$$

• Output current: $I_{OH}/I_{OL} = \pm 12 \text{ mA} \text{ (min)} (V_{CC} = 3.0 \text{ V})$

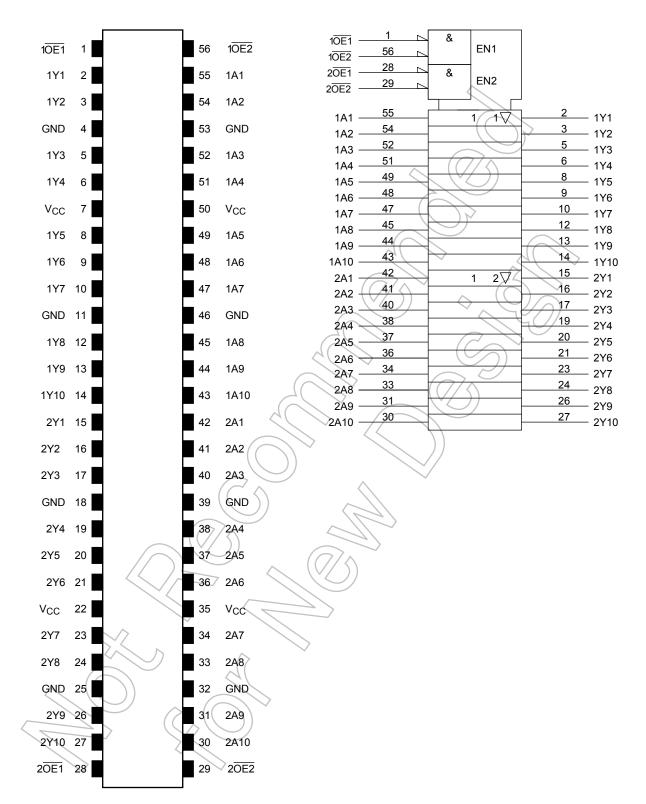
$$: I_{OH}/I_{OL} = \pm 8 \text{ mA (min)} (V_{CC} = 2.3 \text{ V})$$

$$: I_{OH}/I_{OL} = \pm 4 \text{ mA (min)} (V_{CC} = 1.8 \text{ V})$$

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200$ V
 - Human body model ≥ ±2000 V
- Package: TSSOP
- 3.6-V tolerant function and power-down protection control inputs and outputs

Pin Assignment (top view)

IEC Logic Symbol



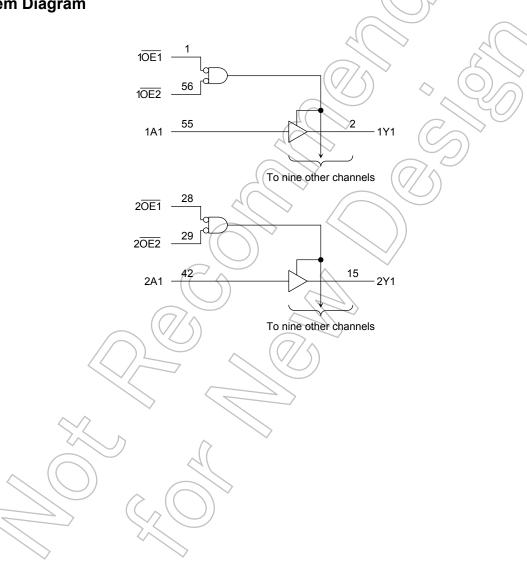
Truth Table (each 10-bit latch)

	Outputs		
OE1	OE2	А	Y
L	L	L	L
L	L	Н	Н
н	Х	Х	Z
Х	Н	Х	Z

X: Don't care

Z: High impedance

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics		Symbol	Rating	Unit	
Power supply voltage		V _{CC}	-0.5 to 4.6	V	
DC input voltage	(OE)	Max	-0.5 to 4.6	v	
DC Input voltage	(An)	V _{IN}	-0.5 to V _{CC} + 0.5	v	
DC output voltage		Varia	-0.5 to 4.6 (Note 2)	V	$\langle \bigcirc \rangle$
		Vout	–0.5 to V _{CC} + 0.5 (Note 3)		75
Input diode current		I _{IK}	-50	mA	
Output diode current		I _{OK}	±50 (Note 4)	mA	>
Output current		IOUT	±50	mA	\frown
Power dissipation		PD	400	mW	
DC V _{CC} /ground curren	t per supply pin	I _{CC} /I _{GND}	±100	mA	\mathcal{L}
Storage temperature		T _{stg}	-65 to 150	°C 🗸	(O)

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 2: OFF state
- Note 3: High or low state. IOUT absolute maximum rating must be observed.
- Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1) (Note 2)

Characteristics		Symbol Rating		Unit	
Power supply voltage		V _{CC}	1.8 to 3.6	V	
Tower supply voltage		vcc	1.2 to 3.6 (Note 3)		
Input voltage	(OE)	V _{IN}	-0.3 to 3.6	v	$\left \right $
input voltage	(An)	۷IN	0 to V _{CC}	v	$\widetilde{\mathcal{C}}$
Output voltage		Vout	0 to 3.6 (Note 4)	V	C
Output voltage		VOUT	0 to V _{CC} (Note 5)		77
			±12 (Note 6)	\mathbb{N}))
Output current		I _{OH} /I _{OL}	±8 (Note 7)	mA	
			±4 (Note 8)	(\bigcirc)	
Operating temperature		T _{opr}	-40 to 85	0°	
Input rise and fall time		dt/dv	0 to 10 (Note 9)	ns/V	

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 2: Floating or unused control inputs must be held high or low.

Note 3: Data retention

- Note 4: OFF state
- Note 5: High or low state
- Note 6: $V_{CC} = 3.0$ to 3.6 V
- Note 7: $V_{CC} = 2.3$ to 2.7 V
- Note 8: V_{CC} = 1.8 V
- Note 9: $V_{IN}=0.8$ to 2.0 V, $V_{CC}=3.0$ V

Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C, 2.7 V < V_{CC} \leq 3.6 V)

Characteris	stics	Symbol	Test Co	ndition	V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level	VIH	—		2.7 to 3.6	2.0		V	
input voltage	L-level	V _{IL}	_	_	2.7 to 3.6	1	0.8	v	
				I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	V _{OH}	VIN = VIH or VIL	I _{OH} = -6 mA	2.7	2.2	_		
		-		I _{OH} = -8 mA	3.0	2.4			
Output voltage				I _{OH} = -12 mA	3.0	2.2		V	
				l _{OL} = 100 μA	2.7 to 3.6		0.2		
	L-level	V _{OL}	V _{OL} V _{IN} = V _{IH} or V _{IL}	I _{OL} = 6 mA	2.7	\mathcal{A}	0.4		
	L-16461			I _{OL} = 8 mA	3.0	$\langle - \rangle$	0.5		
				I _{OL} = 12 mA	3.0(($) \rightarrow a$	0.8		
Input leakage	(OE)	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	Y	±5.0	μA	
current	(An)	IN	$V_{IN} = V_{CC}$ or GND		2.7 to 3.6	\geq	±5.0	μ	
Bushold input minim	um drive	II (HOLD)	V _{IN} = 0.8 V		3.0)	75		μA	
hold current		I (HOLD)	V _{IN} = 2.0 V		3.0	-75	_	μι	
Bushold input over-o	drive current	I _{I (OD)}		(Note 1)	3.6	—	450	μA	
to change state	change state (Note 2		(Note 2)	3.6		-450	μι		
3-state output OFF	state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		2.7 to 3.6	_	±10.0	μA	
Power-off leakage c	urrent	IOFF	V _{OUT} = 0 to 3.6 V	\sim	0	_	10.0	μA	
Ouissant sumply summat			$V_{IN} = V_{CC}$ or GND		2.7 to 3.6		20.0		
Quiescent supply cu		Icc	V _{CC} ≤ V _{OUT} ≤ 3.6 V	(Note 3)	2.7 to 3.6	_	±20.0	μΑ	
Increase in I _{CC} per i	input	Alcc	V _{IH} = V _{CC} – 0.6 V	$\langle \rangle$	2.7 to 3.6	_	750	μA	

Note 1: An external driver must source at least the specified current to switch LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch HIGH-to-LOW.

Note 3: Outputs high impedance only.

2014-03-01

DC Characteristics (Ta = –40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characteris	tics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	VIH	_	_	2.3 to 2.7	1.6	_	V
input voitage	L-level	VIL	—	_	2.3 to 2.7		0.7	v
H-level				I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2		
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -4 mA	2.3	2.0		
				$I_{OH} = -6 \text{ mA}$	2.3	1.8	_	
Output voltage				I _{OH} = -8 mA	2.3	1.7	_	V
L-level		vel V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	l _{OL} = 100 μA	2.3 to 2.7	_	0.2	
	L-level			I _{OL} = 6 mA	2.3	—	0.4	
				I _{OL} = 8 mA	2.3	\square	0.6	
Input leakage	(OE)	lu i	$V_{IN} = 0$ to 3.6 V		2.3 to 2.7	<u>A</u>	±5.0	μA
current	(An)	I _{IN}	$V_{IN} = V_{CC}$ or GND	(7)	2.3 to 2.7	$\langle - \rangle$	>±5.0	μΑ
Bushold input minim	um drive		V _{IN} = 0.7 V		2.3	45) —	۸
hold current		II (HOLD)	V _{IN} = 1.6 V		2.3	45		μA
Bushold input over-c	Irive current			(Note 1)	2.7	~	300	
to change state		I _{I (OD)}	(Note 2).		2.7	—	-300	μA
3-state output OFF s	state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		2.3 to 2.7	_	±10.0	μA
Power-off leakage ci	urrent	I _{OFF}	V _{OUT} = 0 to 3.6 V		0		10.0	μA
	rront	laa	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7		20.0	^
Quiescent supply cu	nent	ICC	V _{CC} ≤ V _{OUT} ≤ 3.6 V	(Note 3)	2.3 to 2.7		±20.0	μA

Note 1: An external driver must source at least the specified current to switch LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch HIGH-to-LOW.

Note 3: Outputs high impedance only.

DC Characteristics (Ta = -40 to 85°C, 1.8 V \leq V_{CC} < 2.3 V)

Characteris	tics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	VIH			1.8 to 2.3	$0.7 \times V_{CC}$	_	V
input voltage	L-level	V _{IL}			1.8 to 2.3	_	$0.2 \times V_{CC}$	v
H-level	H-level	Vон	VIN = VIH or VIL	I _{OH} = -100 μA	1.8	Vcc - 0.2	_	
Output voltage		0.11		$I_{OH} = -4 \text{ mA}$	71.8	1.4		V
	L-level	Voi	$V_{IN} = V_{IH}$ or V_{IL}	l _{OL} = 100 μA	1.8	_	0.2	
L-		VOL V		I _{OL} = 4 mA	1.8	_	0.3	
Input leakage	(OE)	IIN	$V_{IN} = 0$ to 3.6 V		J 1.8	—	±5.0	μA
current	(An)	'IN	$V_{IN} = V_{CC}$ or GND		1.8	Æ	±5.0	μΛ
Bushold input minim	um drive		V _{IN} = 0.36 V		1.8	25	\geq	μA
hold current		II (HOLD)	V _{IN} = 1.26 V	$(7/5)^{\sim}$	1.8	-25	>	μη
Bushold input over-d	Irive current	I _{I (OD)}		(Note 1)	1.8	\mathcal{A}	200	μA
to change state		U (OD)	(Note 2)		1.8		-200	μΛ
3-state output OFF s	state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		1.8	~ _	±10.0	μA
Power-off leakage cu	urrent	I _{OFF}	V _{OUT} = 0 to 3.6 V	\sim (7/	0	_	10.0	μA
	rront		$V_{IN} = V_{CC}$ or GND		1.8	_	20.0	
Quiescent supply cu	ITEIII	ICC	V _{CC} ≤ V _{OUT} ≤ 3.6 V	(Note 3)	1.8	_	±20.0	μA

Note 1: An external driver must source at least the specified current to switch LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch HIGH-to-LOW.

Note 3: Outputs high impedance only

AC Characteristics (Ta = -40 to 85°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500 \Omega$) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
$\langle \rangle$			1.8	1.5	8.2	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	1.0	4.1	ns
	t _{pHL}	~	$\textbf{3.3}\pm\textbf{0.3}$	0.8	3.4	
\sim	4		1.8	1.5	9.8	
3-state output enable time	tpZL	Figure 1, Figure 3	2.5 ± 0.2	1.0	5.9	ns
$ \qquad \qquad$	(t _{pZH})	$\textbf{3.3}\pm\textbf{0.3}$	0.8	4.3		
			1.8	1.5	8.8	
3-state output disable time	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.9	ns
			$\textbf{3.3}\pm\textbf{0.3}$	0.8	4.3	
			1.8	_	0.5	
Output to output skew	t _{osLH}	(Note 2)	2.5 ± 0.2	_	0.5	ns
	t _{osHL}		$\textbf{3.3}\pm\textbf{0.3}$	_	0.5	

Note 1: For $C_L = 50 \text{ pF}$, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design. $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500 \Omega$)

Characteristics	Symbol	Test (Test Condition		Тур.	Unit
Characteriettee	Cymbol		Sonation	$V_{CC}\left(V\right)$	Typ.	Onit
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	1.8	0.15	
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH}=2.5~V,~V_{IL}=0~V$	(Note)	2.5	0.25	V
-,		$V_{IH} = 3.3 \text{ V}, \text{ V}_{IL} = 0 \text{ V}$	(Note)	3.3	0.35	
	V _{OLV}	$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	1.8	-0.15	
Quiet output minimum dynamic V _{OL}		$V_{IH}=2.5~V,~V_{IL}=0~V$	(Note)	2.5	-0.25	V
,		$V_{IH} = 3.3 \text{ V}, \text{ V}_{IL} = 0 \text{ V}$	(Note)	3.3	-0.35	
	V _{OHV}	$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	1.8	1.55	
Quiet output minimum dynamic V _{OH}		$V_{IH} = 2.5 \text{ V}, \text{ V}_{IL} = 0 \text{ V}$	(Note)	2.5	2.05	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	2.65	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

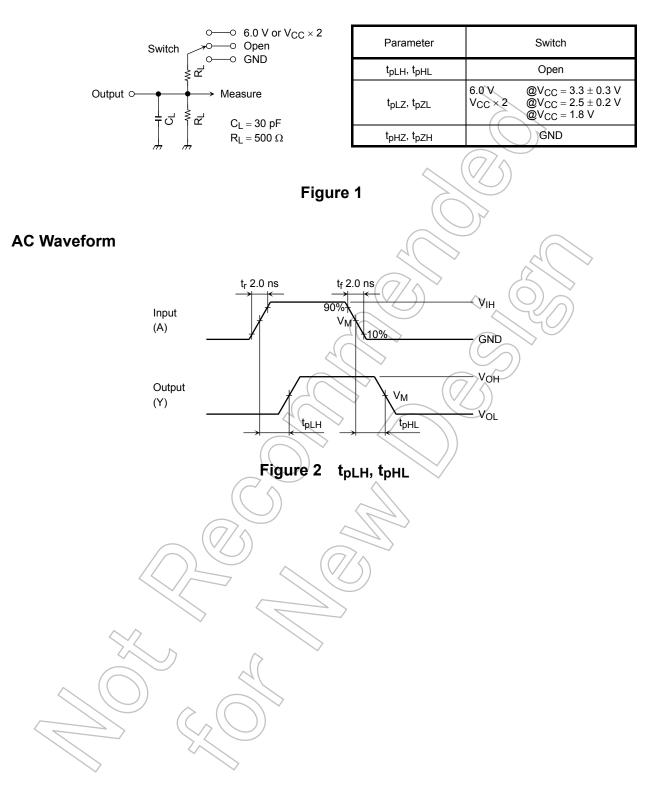
Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}		$(O/\uparrow$	1.8, 2.5, 3.3	6	pF
Output capacitance	CO			1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

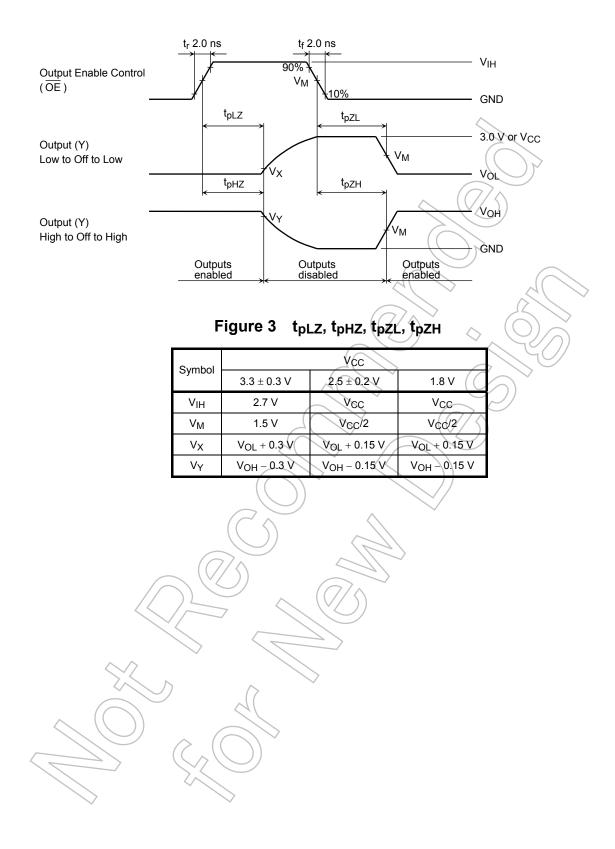
Average operating current can be obtained by the equation: $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/20$ (per bit)

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AC Test Circuit



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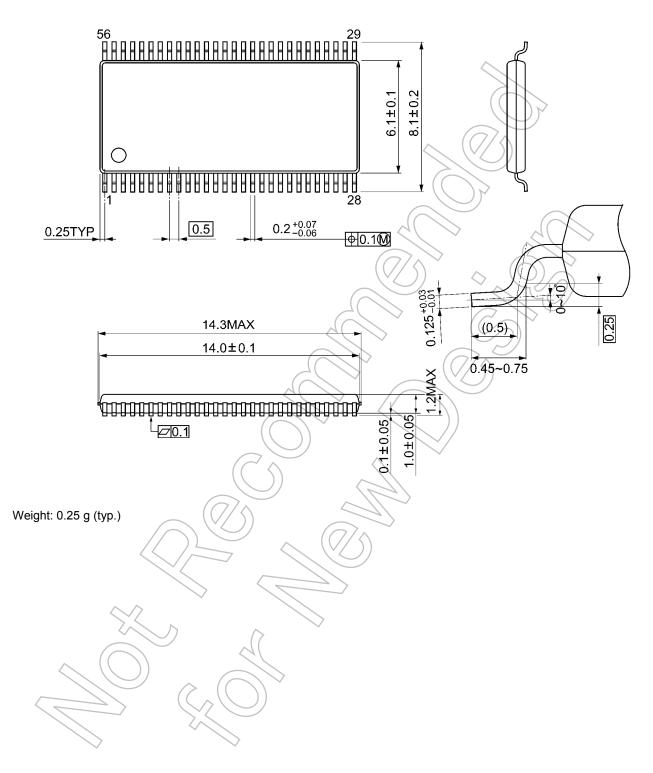




Package Dimensions

TSSOP56-P-0061-0.50A

Unit: mm



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